

# SEA & LAND ELECTRONIC CORP.

www.sealand-pptc.com

# **APPROVAL SHEET**

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DATE: 2014/12/24

SEA & LAND ELECTRONIC CORP.



# nSMD035-13.2V

#### Features

- Surface Mount Devices
- Lead free device
- Size 3.2\*1.6 mm/0.12\*0.06 inch
- Surface Mount packaging for automated assembly

#### Applications

Almost anywhere there is a low voltage power supply, up to 60V and a load to be

protected, including:

- Computer mother board, Modem. USB hub
- PDAs & Charger, Analog & digital line card
- Digital cameras, Disk drivers, CD-ROMs,

Performance Specification

Model	Marking	$V_{max}$	I <sub>max</sub>	I <sub>hold</sub>	I <sub>trip</sub>	$P_d$		mum To Trip	Resis	tance	Agency .	Approval
Model	Marking			@25°C	@25°C	Max.	Current	Time	$Ri_{min}$	R1max	UL	TUV
		(Vdc)	(A)	(A)	(A)	(W)	(A)	(Sec)	(Ω)	$(\Omega)$	OL	101
nSMD035-13.2V	αΒ	13.2	100	0.35	0.75	0.6	8.00	0.10	0.250	1.300		

**Ihold** = Hold Current. Maximum current device will not trip in 25°C still air.

Itrip = Trip Current. Minimum current at which the device will always trip in 25°C still air.

Vmax = Maximum operating voltage device can withstand without damage at rated current (Imax).

Imax = Maximum fault current device can withstand without damage at rated voltage (Vmax).

Pd = Power dissipation when device is in the tripped state in 25°C still air environment at rated voltage.

Rimin/max = Minimum/Maximum device resistance prior to tripping at 25°C.

R1<sub>max</sub> = Maximum device resistance is measured one hour post reflow.

**CAUTION**: Operation beyond the specified ratings may result in damage and possible arcing and flame.

#### **Environmental Specifications**

Test	Conditions	Resistance change
Passive aging	+85°C, 1000 hrs.	±5% typical
Humidity aging	+85°C, 85% R.H., 168 hours	±5% typical
Thermal shock	+85°C to -40°C, 20 times	±33% typical
Resistance to solvent	MIL-STD-202,Method 215	No change
Vibration	MIL-STD-202,Method 201	No change
Ambient operating conditions :	- 40 °C to 85 °C	
Maximum surface temperature of the d	evice in the tripped state is 125 °C	•

Agency Approvals : UL pending

Regulation/Standard:

Pb RoHS

2002/95/EC

HF

EN14582

I<sub>hold</sub> Versus Temperature

Model		Max	timum ambie	ent operating	temperature	e (T <sub>mao</sub> ) vs. h	old current (	(I <sub>hold</sub> )	
Model	-40°C	-20°C	0°C	25°C	40°C	50°C	60°C	70°C	85°C
nSMD035-13.2V	0.50	0.45	0.40	0.35	0.30	0.27	0.24	0.21	0.15



NO. R-50141892



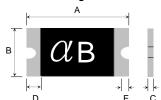
E201504(Alpha-Top)/E319079(Sea&Land)

# nSMD035-13.2V

#### Construction And Dimension (Unit:mm)

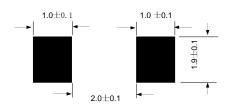
Model	,	A		В			D	E
Model	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Min.
nSMD035-13.2V	3.00	3.50	1.50	1.80	0.50	1.20	0.15	0.10

#### **Dimensions & Marking**



α = Trademark B = Part identification

#### Recommended Pad Layout (mm)



#### **Termination Pad Characteristics**

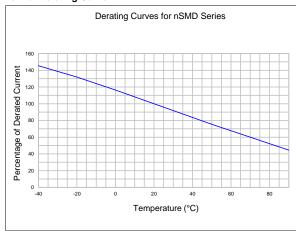
Tin-plated Nickel-Copper Terminal pad materials:

Terminal pad solderability: Meets EIA specification RS186-9E and ANSI/J-STD-002 Category 3.

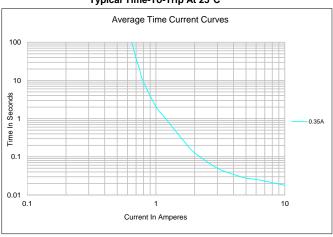
Rework

Use standard industry practices, the removal device must be replaced with a fresh one.

#### **Thermal Derating Curve**



#### Typical Time-To-Trip At 25°C



- Use PPTC beyond the maximum ratings or improper use may result in device damage and possible electrical arcing and flame.

- Use PPIC beyond the maximum ratings or improper use may result in device damage and possible electrical arcing and Hame.

   PPIC are intended for protection against occasional over current or over temperature fault conditions each should not be used when repeated fault conditions or prolonged trip events are anticipated.

   Device performance can be impacted negatively if devices are handled in a manner inconsistent with recommended electronic, thermal, and mechanical procedures for electronic components.

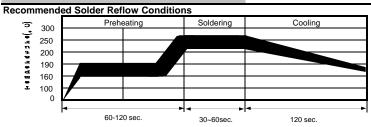
   Use PPIC with a large inductance in circuit will generate a circuit voltage (L di/dt) above the rated voltage of the PPIC.

   Avoid impact PPIC device its thermal expansion like placed under pressure or installed in limited space.

   Contamination of the PPIC material with certain silicon based oils or some aggressive solvents can adversely impact the performance of the devices. PPIC SMD can be cleaned by standard methods.

   Requests that customers comply with our recommended solder pad layouts and recommended reflow profile. Improper board layouts or reflow profile could negatively impact solderability performance of our devices.

# nSMD035-13.2V

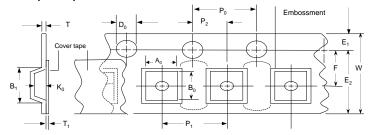


- Recommended reflow methods: IR, vapor phase oven, hot air oven.
- Devices are not designed to be wave soldered to the bottom side
- of the board.
- Recommended maximum paste thickness is 0.25 mm (0.010 inch).
- Devices can be cleaned using standard method and solvents.
- Note: If reflow temperatures exceed the recommended profile, devices may not meet the performance requirements.

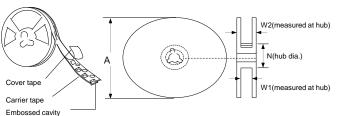
#### Tape And Reel Specifications (mm)

Governing Specifications	EIA 481-1
W	8.15 ± 0.3
P0	4.0 ± 0.10
P1	$4.0 \pm 0.10$
P2	$2.0 \pm 0.05$
A0	1.95 ± 0.10
B0	$3.45 \pm 0.10$
B1max.	4.35
D0	1.5 + 0.1, -0
F	$3.5 \pm 0.05$
E1	1.75 ± 0.10
E2min.	6.25
Tmax.	0.6
T1max.	0.1
K0	1.04 ± 0.1
Leader min.	390
Trailer min.	160
Reel Dimensions	
A max.	178
N min.	60
W1	9 ± 0.5
W2	12.6 ± 0.5

### **EIA Tape Component Dimensions**



### **EIA Reel Dimensions**



# Storage And Handling

- Storage conditions : 40°C max, 70% R.H.
- Devices may not meet specified performance if storage conditions are exceeded.

## Order Information Packaging

Oraci illiorillation			i dokaging
nSMD	035	-13.2V	Tape & Reel Quantity
Product name	Hold	Max	
Size 3216 mm / 1206 inch	Current	Voltage	3500 pcs/reel
SMD: surface mount device	0.354		

Tape & reel packaging per EIA481-1

#### Labeling Information

